NanoSIMS: We expect to take delivery in October 2005 of a new-generation commercial SIMS instrument, the Cameca NanoSIMS 50L (NS50L). This instrument combines high sensitivity, high spatial resolution (<100 nm) and simultaneous collection of multiple ion beams (multi-collection), allowing sub-micron isotopic ratio measurements and isotopic and elemental images to be acquired. The NS50L has significant modifications relative to the first-generation NS50 instrument and will be discussed in detail in the contribution by Messenger [2].

Super-SIMS: The Super-SIMS is a new instrument we are developing, based on adding an additional secondary ion beamline to our existing Cameca ims-6f ion microprobe. The heart of the new mass spectrometer is a 1 m radius electromagnet, which will allow high secondary ion transmission at high mass resolution as well as multi-collection. A schematic design of the instrument is shown in Figure 1. The new beamline shares the ims-6f primary ion column, sample chamber, electron flood gun, and ion transfer optics. By removing voltage from the ims-6f electrostatic analyzer (ESA), the secondary ion beam passes through a small hole drilled in the outer ESA electrode and into the new beamline. The mass spectrometer itself consists of a large custom-built ESA, the large-radius magnet, several ion-optical components for shaping and steering the beam, and a multi-collector system allowing at least seven ion detectors to be individually moved along the focal plane of the magnet. The mass dispersion on the focal plane will permit positioning of the detectors at unit mass spacing up to mass 70. Following the multi-collector is a projection lens system for projecting an image of the ion beam onto a micro-channel plate detector for tuning purposes. The ion-optical design has been optimized through a combination of computer modeling and experimental trial-and-error. The major components of the instrument have been constructed and assembled and we can routinely image the secondary ion beam transferred from the ims-6f sample chamber through to the focal plane of the magnet. Initial multi-collection C-isotope measurements...
indicate good (~1‰) isotope reproducibility, but lower secondary ion transmission than anticipated. A new, larger ESA under construction is expected to improve transmission. Although the spatial resolution of the Super-SIMS (~1μm) is lower than that of the NanoSIMS, the new instrument is expected to have comparable transmission to the NanoSIMS when completed, and to provide better isotopic reproducibility. Thus, it will probably be most useful for “bulk” high-precision isotopic measurements of returned samples, whereas the NanoSIMS will be used to determine isotopic variability on small spatial scales and identify anomalous materials.

**SEM:** Our scanning electron microscopy facility includes a JEOL 6500F thermal field emission SEM equipped with secondary and backscatter electron detectors, and an EDAX/TSL analysis system consisting of an EDS spectrometer, a WDS spectrometer and an electron backscatter diffraction (EBSD) camera. Also installed is a Kleindiek M3 micromanipulator, useful for handling small particles while viewing them in the SEM. The WDS spectrometer (“LEXS”) uses special optics to boost sensitivity for low-energy (<2.5 keV) x-rays, allowing high signal-to-noise mapping of light elements (e.g., C and N) with relatively low currents in the SEM. We are exploring the use of EBSD for particle analysis, particularly for the identification of specific crystal phases within extraterrestrial materials [3].

**References**

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**FIG 1:** Scaled layout of the large-radius mass spectrometer (Super-SIMS) showing its connection to the existing Cameca ims-6f. Secondary ion beam paths are shown for the 6f (black) and for the Super-SIMS (green). The existing 6f entrance slit assembly forms the object for both mass spectrometers, and a hole drilled in the outer electrode of the 6f ESA permits passage of the secondary ion beam into the large-radius instrument.